

QSD12HCS65U 650V 12A Homogeneous Current Silicon Carbide Schottky Diode

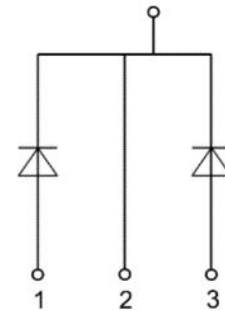


VRRM =	650 V
IF (TC=135 °C) =	18 A
QC =	46 nC

General Description

- Replace Bipolar with Unipolar Rectifiers
- Essentially No Switching Losses
- Higher Efficiency
- Reduction of Heat Sink Requirements
- Parallel Devices Without Thermal Runaway

Package



Features

- 650V Schottky Rectifier
- Zero Reverse Recovery Current
- High-Frequency Operation
- Temperature-Independent Switching Behavior
- Extremely Fast Switching

Typical Applications

- Switch Mode Power Supplies (SMPS)
- Power Factor Correction
- Motor Drives

Part Number	Package	Marking
QSD12HSC65U	T0247-3L	Queensland Semi

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Maximum Rated Values (TC=25°C unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
VRRM	Repetitive Peak Reverse Voltage	650	V		
VR	DC Peak Reverse Voltage	650	V		
IF(DC)	Forward DC Current	6	A	Per Leg	
		12		Both legs	
IFP	Forward pulse Current	60	A	Per Leg	Note1
		120		Both legs	
IFSM	Non-Repetitive Forward Surge Current	38	A	Per Leg	Note2
		66		Both legs	
Ptot	Power Dissipation	107	W	Per Leg	Note3
		188		Both legs	
TJ	Operating Temperature	-55 to +175	°C		
Tstg	Storage Temperature	-55 to +175	°C		
	TO-247 Mounting Torque	1 8.8	Nm I bf-in	M3 Screw 6-32 Screw	

Note1:t=50µs

Note2:f=50Hz(half-sine wave,t=10ms)

Note3:TC=25°C

Electrical Characteristics (TJ=25°C)

Symbol	Parameter	Value			Unit	Test Conditions	Note
		Min.	Typ.	Max.			
VF	Forward Voltage		1.1		V	IF=3A, TJ=25°C	Fig. 1
			1.3	1.6		IF=6A, TJ=25°C	
IR	Reverse Current		0.95	30	µA	VR=650V, TJ=25°C	Fig. 3
			27			VR=650V, TJ=175°C	
QC	Total Capacitive Charge		46		nC	VR=650V,TJ=25°C	Fig. 5
C	Total Capacitance		492		pF	VR=0V, TJ=25°C, f=1MHz	Fig. 4
			62			VR=400V, TJ=25°C, f=1MHz	
			61			VR=650V, TJ=25°C, f=1MHz	

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Thermal Characteristics

Symbol	Parameter	Test Condition	Value	Unit	Note
R _{θJC}	Thermal Resistance(Junction to Case)	Per Leg	1.4	°C/W	
		Both Legs	0.8	°C/W	Fig. 6
R _{θJA}	Thermal Resistance(Junction to ambient)	-	29	°C/W	

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Typical Performance Characteristics

Figure 1. Forward Characteristics

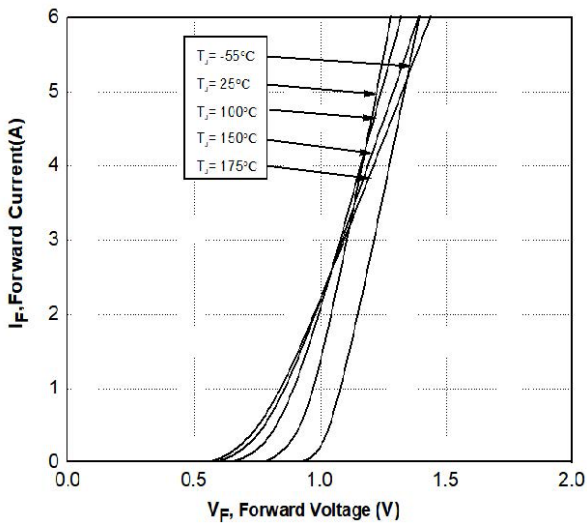


Figure 2. Forward Characteristics

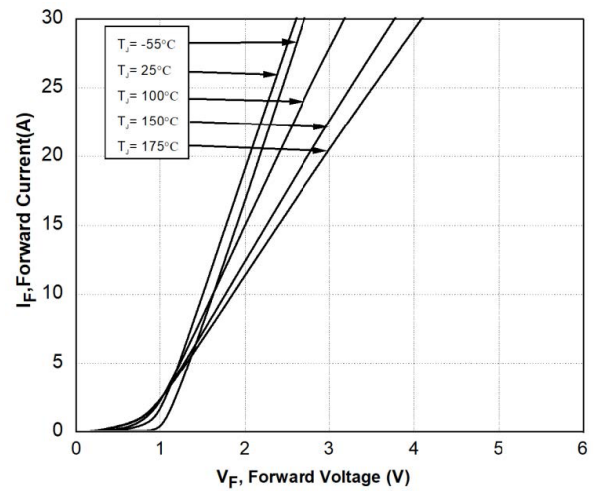


Figure 3. Reverse Characteristics

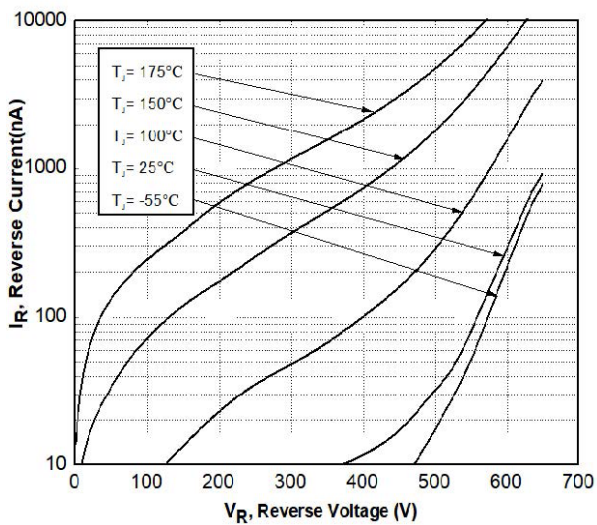
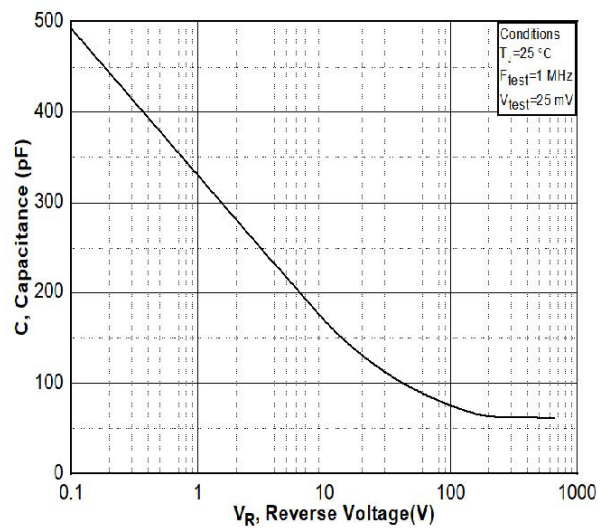


Figure 4. Capacitance Vs. Reverse Voltage



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Figure 5. Capacitance Charge Vs. Reverse Voltage

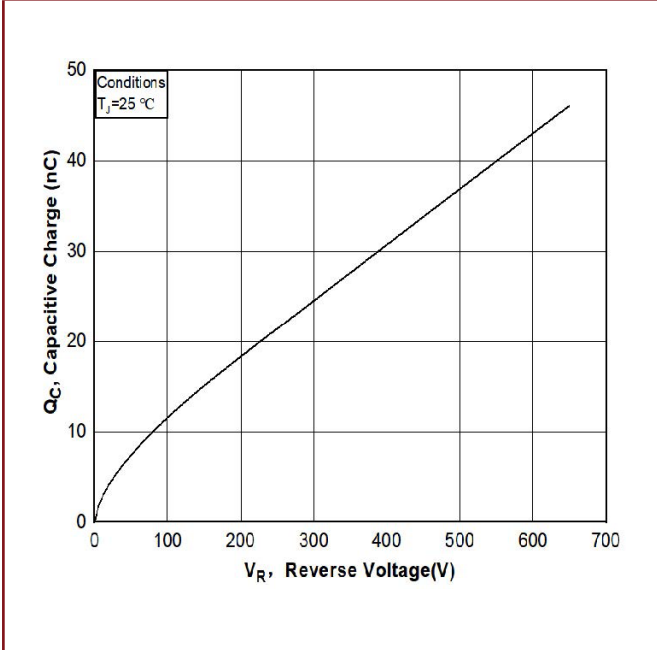
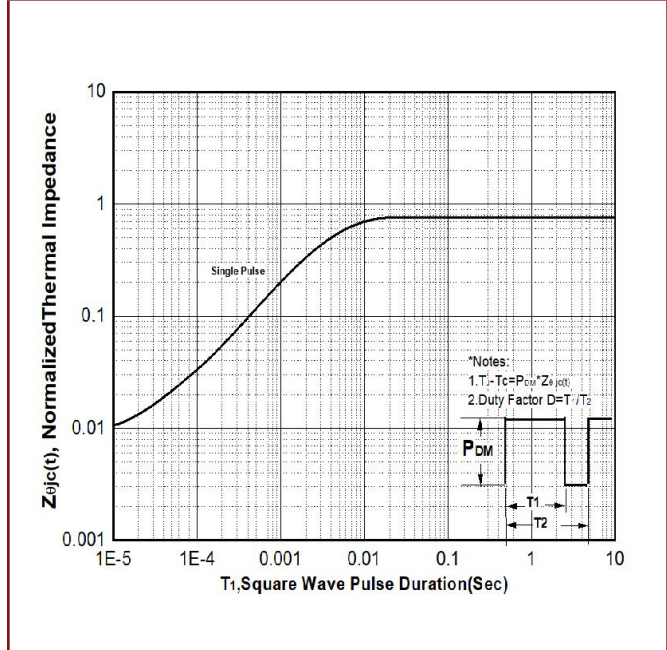


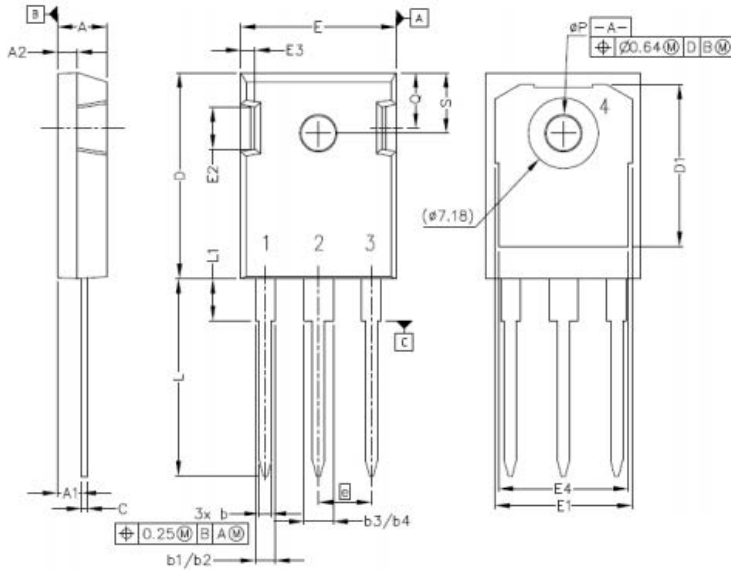
Figure 6. Transient Thermal Response Curve(Junction-to-Case)



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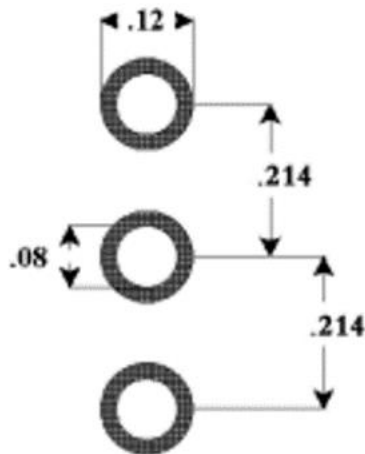


Package Dimensions



POS	Inches		Millimeters	
	Min	Max	Min	Max
A	.190	.205	4.83	5.21
A1	.090	.100	2.29	2.54
A2	.075	.085	1.91	2.16
b	.042	.052	1.07	1.33
b1	.075	.095	1.91	2.41
b2	.075	.085	1.91	2.16
b3	.113	.133	2.87	3.38
b4	.113	.123	2.87	3.13
c	.022	.027	0.55	0.68
D	.819	.831	20.80	21.10
D1	.640	.695	16.25	17.65
D2	.037	.049	0.95	1.25
E	.620	.635	15.75	16.13
E1	.516	.557	13.10	14.15
E2	.145	.201	3.68	5.10
E3	.039	.075	1.00	1.90
E4	.487	.529	12.38	13.43
e	.214 BSC		5.44 BSC	
N	3		3	
L	.780	.800	19.81	20.32
L1	.161	.173	4.10	4.40
ØP	.138	.144	3.51	3.65
Q	.216	.236	5.49	6.00
S	.238	.248	6.04	6.30
T	9°	11°	9°	11°
U	9°	11°	9°	11°
V	2°	8°	2°	8°
W	2°	8°	2°	8°

Package Dimensions



Part Number	Package	Marking
QSD12HSC65U	TO247-3L	Queensland Semi

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